

100325 Low Power Hex ECL-to-TTL Translator

General Description

The 100325 is a hex translator for converting F100K logic levels to TTL logic levels. Differential inputs allow each circuit to be used as an inverting, non-inverting or differential receiver. An internal reference voltage generator provides V_{BB} for single-ended operation, or for use in Schmitt trigger applications. All inputs have 50k Ω pull-down resistors. When the inputs are either unconnected or at the same potential the outputs will go LOW.

When used in single-ended operation the apparent input threshold of the true inputs is 20mV to 40mV higher (positive) than the threshold of the complementary inputs. The V_{EE} and V_{TTL} power may be applied in either order.

Features

- Pin/function compatible with 100125
- Meets 100125 AC specifications
- 50% power reduction of the 100125
- Differential inputs with built in offset
- Standard FAST® outputs
- 2000V ESD protection
- -4.2V to -5.7V operating range
- Available to industrial grade temperature range

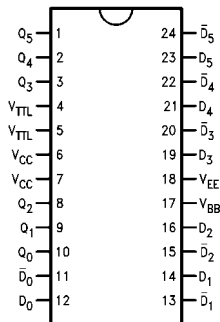
Ordering Code:

| Order Number | Package Number | Package Description |
|--------------|----------------|--|
| 100325SC | M24B | 24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide |
| 100325PC | N24E | 24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide |
| 100325QI | V28A | 28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square |
| 100325QC | V28A | 28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Industrial Temperature Range (-40°C to +85°C) |

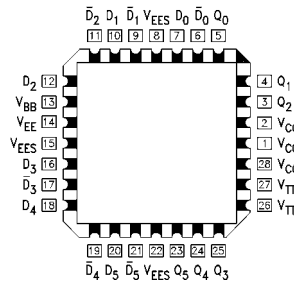
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagrams

24-Pin DIP/SOIC



28-Pin PLCC



Pin Descriptions

| Pin Names | Description |
|---------------------------|-----------------------|
| D_0 - D_5 | Data Inputs |
| \bar{D}_0 - \bar{D}_5 | Inverting Data Inputs |
| Q_0 - Q_5 | Data Outputs |

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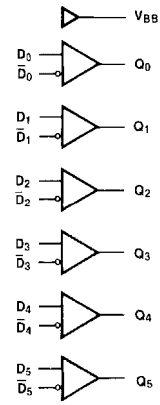
100325

Truth Table

| Inputs | | Outputs |
|----------|-------------|---------|
| D_n | \bar{D}_n | Q_n |
| L | H | L |
| H | L | H |
| L | L | L |
| H | H | L |
| OPEN | OPEN | L |
| V_{EE} | V_{EE} | L |
| L | V_{BB} | L |
| H | V_{BB} | H |
| V_{BB} | L | H |
| V_{BB} | H | L |

H = HIGH Voltage Level
L = LOW Voltage Level

Logic Diagram



| Absolute Maximum Ratings ^(Note 1) | | | | Recommended Operating Conditions | | | | | |
|---|---------------------------------|----------------|-------|----------------------------------|-------------------------|--|-------------------------|-------|-------------------------------|
| Storage Temperature (T_{STG}) | -65°C to +150°C | | | Case Temperature (T_C) | Commercial 0°C to +85°C | | | | |
| Maximum Junction Temperature (T_J) | +150°C | | | Industrial | -40°C to +85°C | | | | |
| V_{EE} Pin Potential to Ground Pin | -7.0V to +0.5V | | | Supply Voltage (V_{EE}) | -5.7V to -4.2V | | | | |
| V_{TTL} Pin Potential to Ground Pin | -0.5V to +6.0V | | | | | | | | |
| Input Voltage (DC) | V_{EE} to +0.5V | | | | | | | | |
| Voltage Applied to Output | | | | | | | | | |
| in HIGH State (with $V_{CC} = 0V$) | -0.5V to V_{CC} | | | | | | | | |
| Current Applied to Output | | | | | | | | | |
| in LOW State (Max) | twice the rated I_{OL} (mA) | | | | | | | | |
| ESD (Note 2) | ≥2000V | | | | | | | | |
| <p>Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.</p> <p>Note 2: ESD testing conforms to MIL-STD-883, Method 3015.</p> | | | | | | | | | |
| Commercial Version | | | | | | | | | |
| DC Electrical Characteristics | | | | | | | | | |
| $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $5.5V$, $T_C = 0°C$ to $+85°C$ (Note 3) | | | | | | | | | |
| Symbol | Parameter | Min | Typ | Max | Units | Conditions | | | |
| V_{BB} | Output Reference Voltage | -1380 | -1320 | -1260 | mV | $I_{VBB} = -2.1$ mA | | | |
| V_{IH} | Single-Ended Input HIGH Voltage | -1165 | | -870 | mV | Guaranteed HIGH Signal for All Inputs (with One Input Tied to V_{BB}) | | | |
| V_{IL} | Single-Ended Input LOW Voltage | -1830 | | -1475 | mV | Guaranteed LOW Signal for All Inputs (with One Input Tied to V_{BB}) | | | |
| V_{OH} | Output HIGH Voltage | 2.5 | | | V | $I_{OH} = -2.0$ mA | $V_{IN} = V_{IH} (Max)$ | | |
| V_{OL} | Output LOW Voltage | | | 0.5 | V | $I_{OL} = 20$ mA | or $V_{IL} (Min)$ | | |
| V_{DIFF} | Input Voltage Differential | 150 | | | mV | Required for Full Output Swing | | | |
| V_{CM} | Common Mode Voltage | $V_{CC} - 2.0$ | | $V_{CC} - 0.5$ | V | | | | |
| I_{IH} | Input HIGH Current | | | 350 | μA | $V_{IN} = V_{IH} (Max)$, $D_0-D_5 = V_{BB}$, $\bar{D}_0-\bar{D}_5 = V_{IL} (Min)$ | | | |
| I_{IL} | Input LOW Current | 0.5 | | | μA | $V_{IN} = V_{IL} (Min)$, $D_0-D_5 = V_{BB}$ | | | |
| I_{OS} | Output Short-Circuit Current | -150 | | -60 | mA | $V_{OUT} = GND$ (Note 4) | | | |
| I_{EE} | V_{EE} Power Supply Current | -37 | -27 | -17 | mA | $D_0-D_5 = V_{BB}$ | | | |
| I_{TTL} | V_{TTL} Power Supply Current | | 45 | 65 | mA | $D_0-D_5 = V_{BB}$ | | | |
| <p>Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.</p> <p>Note 4: Test one output at a time.</p> | | | | | | | | | |
| DIP AC Electrical Characteristics | | | | | | | | | |
| $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $+5.5V$ | | | | | | | | | |
| Symbol | Parameter | $T_C = 0°C$ | | $T_C = +25°C$ | | $T_C = +85°C$ | | Units | Conditions |
| | | Min | Max | Min | Max | Min | Max | | |
| t_{PLH} | Propagation Delay | | | | | | | ns | $C_L = 15$ pF Figures 1, 2 |
| t_{PHL} | Data to Output | 0.80 | 3.50 | 0.90 | 3.70 | 1.00 | 4.00 | | |
| t_{PLH} | Propagation Delay | | | | | | | ns | $C_L = 50$ pF Figures 1, 3 |
| t_{PHL} | Data to Output | 1.60 | 4.30 | 1.70 | 4.50 | 1.80 | 4.80 | | |

Commercial Version (Continued) SOIC and PLCC AC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $+5.5V$

| Symbol | Parameter | $T_C = 0^\circ C$ | | $T_C = +25^\circ C$ | | $T_C = +85^\circ C$ | | Units | Conditions |
|------------------------|---|-------------------|------|---------------------|------|---------------------|------|-------|-------------------------------|
| | | Min | Max | Min | Max | Min | Max | | |
| t_{PLH} t_{PHL} | Propagation Delay Data to Output | 0.80 | 3.30 | 0.90 | 3.50 | 1.00 | 3.80 | ns | $C_L = 15$ pF Figures 1, 2 |
| t_{PLH} t_{PHL} | Propagation Delay Data to Output | 1.60 | 4.10 | 1.70 | 4.30 | 1.80 | 4.60 | ns | $C_L = 50$ pF Figures 1, 3 |
| t_{OSHL} | Maximum Skew Common Edge Output-to-Output Variation Data to Output Path | | 0.65 | | 0.65 | | 0.65 | ns | PLCC Only (Note 5) |
| t_{OSLH} | Maximum Skew Common Edge Output-to-Output Variation Data to Output Path | | 0.65 | | 0.65 | | 0.65 | ns | PLCC Only (Note 5) |
| t_{OST} | Maximum Skew Opposite Edge Output-to-Output Variation Data to Output Path | | 2.20 | | 2.20 | | 2.20 | ns | PLCC Only (Note 5) |
| t_{PS} | Maximum Skew Pin (Signal) Transition Variation Data to Output Path | | 2.10 | | 2.10 | | 2.10 | ns | PLCC Only (Note 5) |

Note 5: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}), or LOW-to-HIGH (t_{OSLH}), or in opposite directions both HL and LH (t_{OST}). Parameters t_{OST} and t_{PS} guaranteed by design.

Industrial Version

PLCC DC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $T_C = -40^\circ C$ to $+85^\circ C$ (Note 6)

| Symbol | Parameter | $T_C = -40^\circ C$ | | $T_C = 0^\circ C$ to $+85^\circ C$ | | Units | Conditions |
|------------|---------------------------------|---------------------|----------------|------------------------------------|----------------|---------|--|
| | | Min | Max | Min | Max | | |
| V_{BB} | Output Reference Voltage | -1395 | -1255 | -1380 | -1260 | mV | $I_{V_{BB}} = -2.1$ mA |
| V_{IH} | Single-Ended Input HIGH Voltage | -1170 | -870 | -1165 | -870 | mV | Guaranteed HIGH Signal for All Inputs (with One Input Tied to V_{BB}) |
| V_{IL} | Single-Ended Input LOW Voltage | -1830 | -1480 | -1830 | -1475 | mV | Guaranteed LOW Signal for All Inputs (with One Input Tied to V_{BB}) |
| V_{OH} | Output HIGH Voltage | 2.5 | | 2.5 | | V | $I_{OH} = -2.0$ mA |
| V_{OL} | Output LOW Voltage | | 0.5 | | 0.5 | V | $I_{OL} = 20$ mA |
| V_{DIFF} | Input Voltage Differential | 150 | | 150 | | mV | Required for Full Output Swing |
| V_{CM} | Common Mode Voltage | $V_{CC} - 2.0$ | $V_{CC} - 0.5$ | $V_{CC} - 2.0$ | $V_{CC} - 0.5$ | V | |
| I_{IH} | Input HIGH Current | | 450 | | 350 | μA | $V_{IN} = V_{IH} (Max)$, $D_0-D_5 = V_{BB}$, $\bar{D}_0-\bar{D}_5 = V_{IL} (Min)$ |
| I_{IL} | Input LOW Current | 0.5 | | 0.5 | | μA | $V_{IN} = V_{IL} (Min)$, $D_0-D_5 = V_{BB}$ |
| I_{OS} | Output Short-Circuit Current | -150 | -60 | -150 | -60 | mA | $V_{OUT} = GND$ (Note 7) |
| I_{EE} | V_{EE} Power Supply Current | -37 | -15 | -37 | -17 | mA | $D_0-D_5 = V_{BB}$ |
| I_{TTL} | V_{TTL} Power Supply Current | | 65 | | 65 | mA | $D_0-D_5 = V_{BB}$ |

Note 6: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

Note 7: Test one output at a time.

PLCC AC Electrical Characteristics

$V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = GND$, $V_{TTL} = +4.5V$ to $+5.5V$

| Symbol | Parameter | $T_C = -40^\circ C$ | | $T_C = +25^\circ C$ | | $T_C = +85^\circ C$ | | Units | Conditions |
|-----------|-------------------|---------------------|------|---------------------|------|---------------------|------|-------|---------------|
| | | Min | Max | Min | Max | Min | Max | | |
| t_{PLH} | Propagation Delay | | | | | | | ns | $C_L = 15$ pF |
| t_{PHL} | Data to Output | 0.80 | 3.30 | 0.90 | 3.50 | 1.00 | 3.80 | | Figures 1, 2 |
| t_{PLH} | Propagation Delay | | | | | | | ns | $C_L = 50$ pF |
| t_{PHL} | Data to Output | 1.60 | 4.10 | 1.70 | 4.30 | 1.80 | 4.60 | | Figures 1, 3 |

Switching Waveform

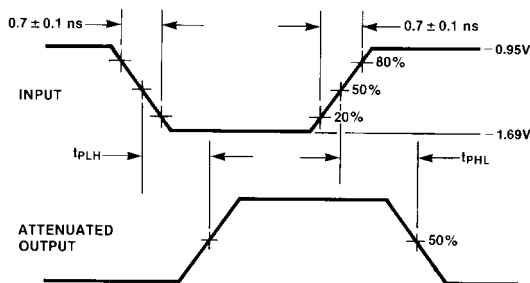
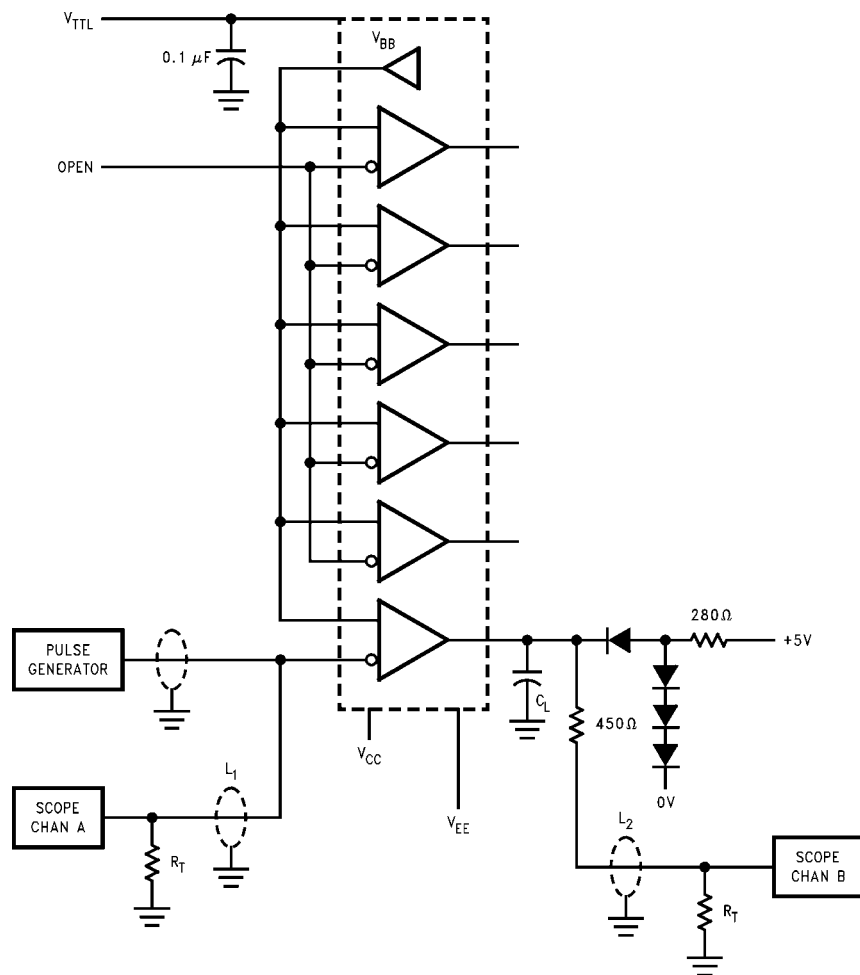


FIGURE 1. Propagation Delay

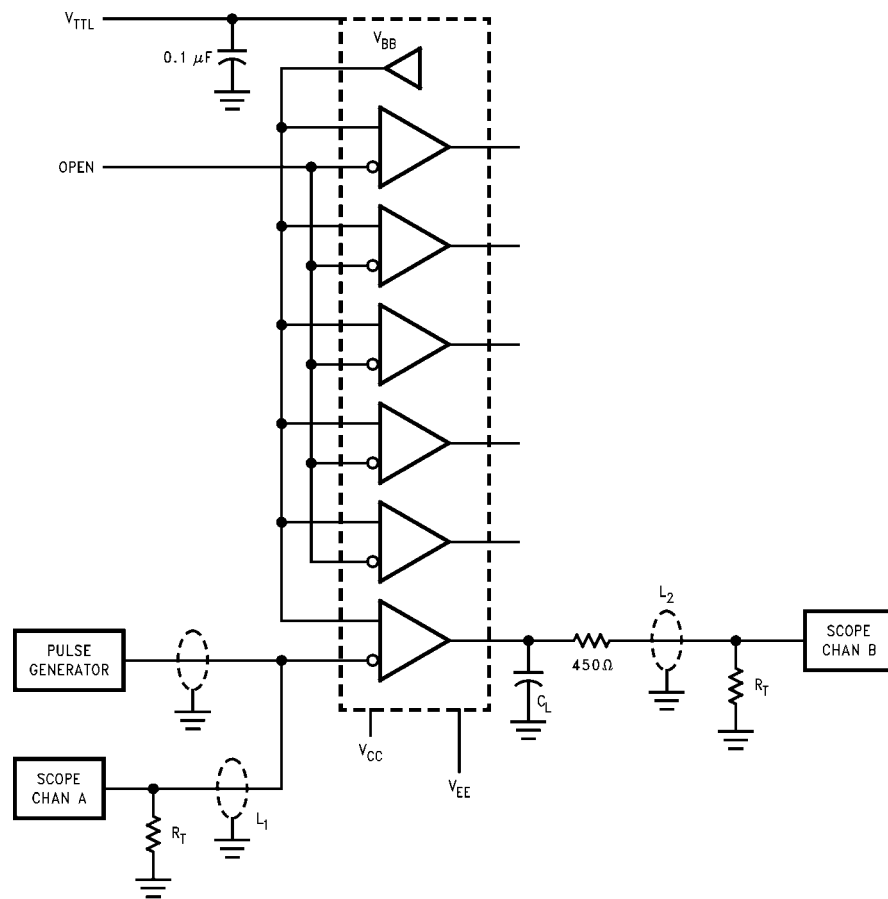
Test Circuits

**Note:**

- $V_{CC} = 0V$, $V_{EE} = -4.5V$, $V_{TTL} = +5V$
- $L1$ and $L2$ = equal length 50Ω impedance lines
- $R_T = 50\Omega$ terminator internal to scope
- Decoupling $0.1 \mu F$ from GND to V_{CC} , V_{EE} and V_{TTL}
- All unused outputs are loaded with 500Ω to GND
- C_L = Fixture and stray capacitance = 15 pF

FIGURE 2. AC Test Circuit for 15 pF Loading

Test Circuits (Continued)

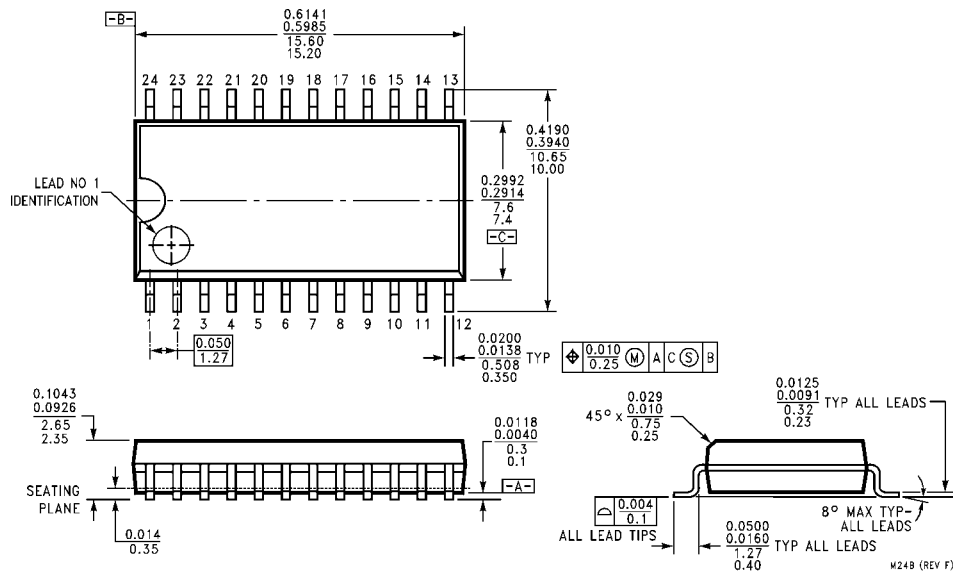


Note:

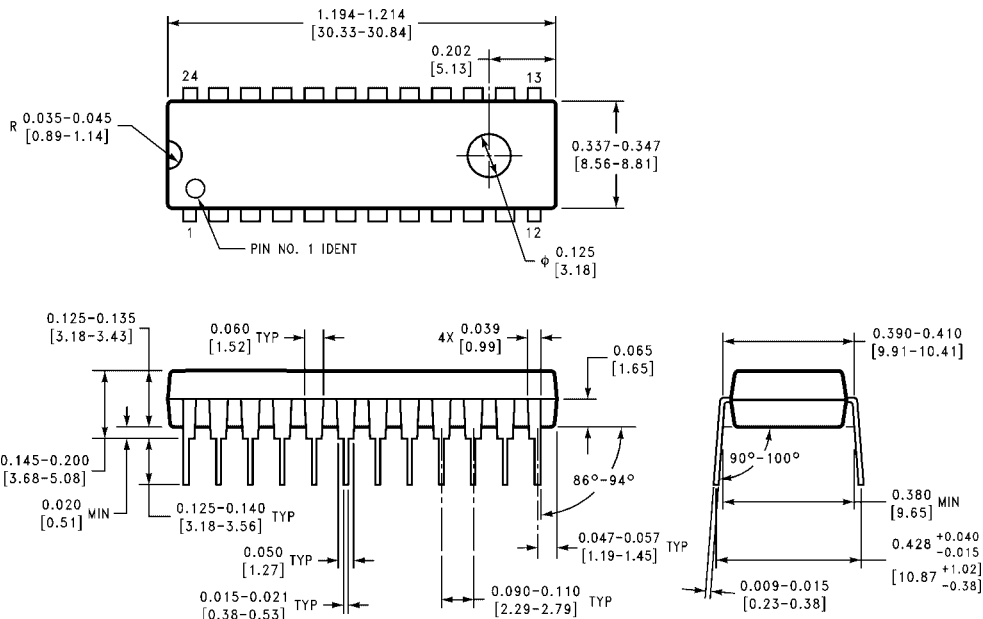
- $V_{CC} = 0V$, $V_{EE} = -4.5V$, $V_{TTL} = +5V$
- L_1 and L_2 = equal length 50Ω impedance lines
- $R_T = 50\Omega$ terminator internal to scope
- Decoupling $0.1 \mu F$ from GND to V_{CC} , V_{EE} and V_{TTL}
- All unused outputs are loaded with 500Ω to GND
- C_L = Fixture and stray capacitance = 50 pF

FIGURE 3. AC Test Circuit for 50 pF Loading

Physical Dimensions inches (millimeters) unless otherwise noted

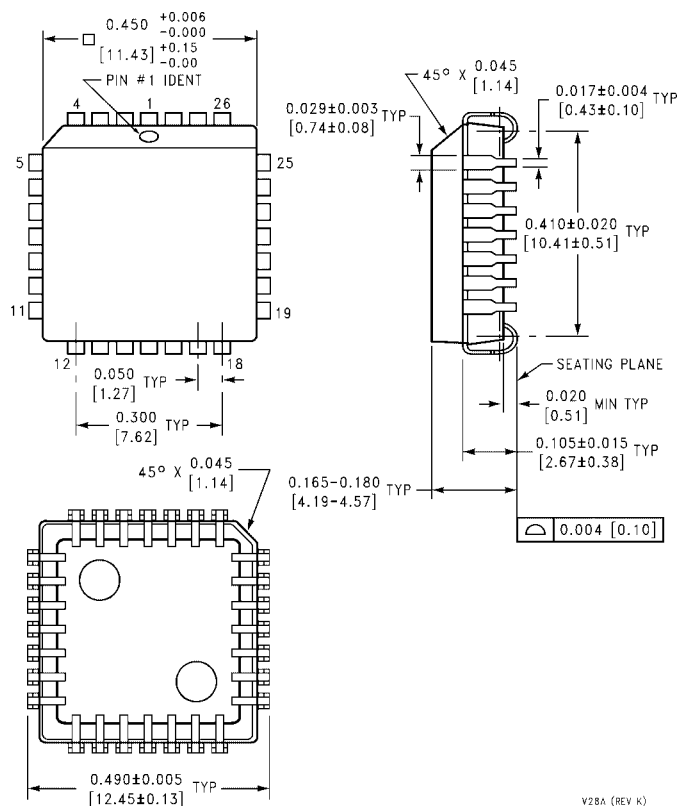


24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide Package Number M24B



24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide Package Number N24E

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
Package Number V28A**

V28A (REV K)

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